

<b>Issue Classification</b>			Application No.	Applicant(s)	
			09/725,836	SUN ET AL.	
			Examiner	Art Unit	
			Jinhee J Lee	2831	



ORIGINAL			CROSS REFERENCE(S)					
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
174	138R	174	138C					
INTERNATIONAL CLASSIFICATION			310	309				
H	0	1	b	5/00	439	492	31	496
			/	200	181			
			/					
			/					
			/					
Jinhee Lee (Assistant Examiner) (Date)			<i>Kleen A. Reichard</i> DEAN A. REICHARD 3/8/04 SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800 (Primary Examiner) (Date)			Total Claims Allowed: 20		
Dawn Evans 3/9/04 (Legal Instruments Examiner) (Date)						O.G. Print Claim(s) 19	O.G. Print Fig. 2,3	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
	1	13	31	61	91	121	151
2		14	32	62	92	122	152
3		15	33	63	93	123	153
4		16	34	64	94	124	154
5		17	35	65	95	125	155
6		18	36	66	96	126	156
7		19	37	67	97	127	157
8		20	38	68	98	128	158
9		39		69	99	129	159
10		40		70	100	130	160
11		41		71	101	131	161
12		42		72	102	132	162
13		43		73	103	133	163
14		44		74	104	134	164
15		45		75	105	135	165
16		46		76	106	136	166
17		47		77	107	137	167
18		48		78	108	138	168
1	19	49		79	109	139	169
2	20	50		80	110	140	170
3	21	51		81	111	141	171
4	22	52		82	112	142	172
5	23	53		83	113	143	173
6	24	54		84	114	144	174
7	25	55		85	115	145	175
8	26	56		86	116	146	176
9	27	57		87	117	147	177
10	28	58		88	118	148	178
11	29	59		89	119	149	179
12	30	60		90	120	150	180